

## **Diode EMCON 4 Medium Power Chip**

### FEATURES:

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1200V EMCON 4 technology •

small temperature coefficient

soft, fast switching • low reverse recovery charge

### This chip is used for:

low / medium power modules •



### **Applications:**

low / medium power drives •

Chip Type	V <sub>R</sub>	I <sub>F</sub>	Die Size	Package
IDC51D120T6M	1200V	100A	7.00 x 7.30 mm <sup>2</sup>	sawn on foil

### **MECHANICAL PARAMETER:**

Raster size	7.00 x 7.30				
Area total / active	51.10 / 39.99	mm <sup>2</sup>			
Anode pad size	6.046 x 6.346				
Thickness	110	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	277 pcs				
Passivation frontside	Photoimide				
Pad metall	3200 nm AlSiCu	3200 nm AlSiCu			
Backside metall	Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500µm				
Reject ink dot size	Ø 0.65mm; max 1.2mm				
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



## **Maximum Ratings**

Parameter	Symbol Condition		Value	Unit	
Repetitive peak reverse voltage	V <sub>RRM</sub>		1200	V	
Continuous forward current limited by $T_{jmax}$	I <sub>F</sub>		1)	^	
Maximum repetitive forward current limited by T <sub>jmax</sub>	I <sub>FRM</sub>		200	A	
Operating junction and storage temperature	$T_{\rm j}$ , $T_{\rm stg}$		-40+175	°C	
Safe operating area <sup>2</sup> (SOA)	P <sub>Max</sub>	Tvj= 150°C	tbd	kW	

<sup>1)</sup> depending on thermal properties of assembly

<sup>2)</sup> not subject to production test- verified by design/characterisation

## Static Electrical Characteristics (tested on wafer), $T_i=25$ °C

Parameter	Symbol	Condi	Value			Unit	
Falallelel	Symbol	Condi	luons	min.	Тур.	max.	Unit
Reverse leakage current	I <sub>R</sub>	V <sub>R</sub> =1200V	$T_j=25^\circ C$			18	μA
Cathode-Anode breakdown Voltage	V <sub>Br</sub>	I <sub>R</sub> =0.25mA	<i>T<sub>j</sub></i> =25°C	1200			V
Forward voltage drop	V <sub>F</sub>	I <sub>F</sub> = 100A	<i>T<sub>j</sub>=25°C</i>	1.35	1.7	2.05	V

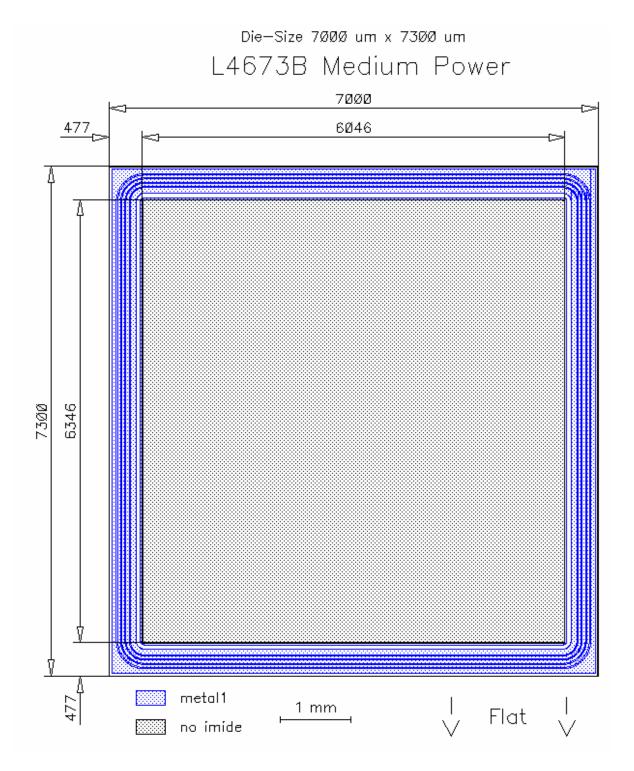
## **Dynamic Electrical Characteristics** inductive load (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions		Value <sup>2)</sup>			Unit
	Symbol			min.	Тур.	max.	
Peak reverse recovery current	I <sub>RM</sub>	$I_{F}=A$ $di/dt=A/\mu s$ $V_{R}=V$ $V_{GE}=-15V$	$T_{j} = 25 \ ^{\circ}C$ $T_{j} = 125 \ ^{\circ}C$ $T_{j} = 150 \ ^{\circ}C$		tbd		A
Reverse recovery charge	Q <sub>r</sub>	$I_{F}=A$ $di/dt=A/\mu s$ $V_{R}=V$ $V_{GE}=-15V$	$T_{j} = 25 \ ^{\circ}C$ $T_{j} = 125 \ ^{\circ}C$ $T_{j} = 150 \ ^{\circ}C$		tbd		μC
Reverse recovery energy	E <sub>rec</sub>	$I_F = A$ $di/dt = A/\mu s$ $V_R = V$ $V_{GE} = -15V$	$T_{j} = 25 \ ^{\circ}C$ $T_{j} = 125 \ ^{\circ}C$ $T_{j} = 150 \ ^{\circ}C$		tbd		mJ

<sup>2)</sup> values also influenced by parasitic L- and C- in measurement and package.



**CHIP DRAWING:** 





### FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

tbd

### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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